Search Notes



Appl	icatior	/Cont	rol No.

10574131

Applicant(s)/Patent Under Reexamination

YANAI ET AL.

Examiner

Art Unit

David N Werner

2621

	SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Espacenet	2010.04.14	DNW
EAST	2010.04.21	DNW
Edan Double Patent Check	2010.04.22	DNW

	INTERFERENCE SEARCH		
Class	Subclass	Date	Examiner

ı	
ı	
ı	
ı	

U.S. Patent and Trademark Office Part of Paper No.: 20100413